1. OVERVIEW

The CF7060xAV/WF7060xAV series are differential output oscillator ICs of the LVDS output type. They support 125degree operation and wide range of output frequencies.

They are suitable for high frequency applications such as high speed communication devices.

They use an oscillation circuit suitable for small crystal elements, therefore suitable for a small package oscillation module.

2. FEATURES

Operating supply voltage:

Recommended oscillation frequency (f_0) :

• Output frequency (f_{OUT}) :

Oscillator capacitances:

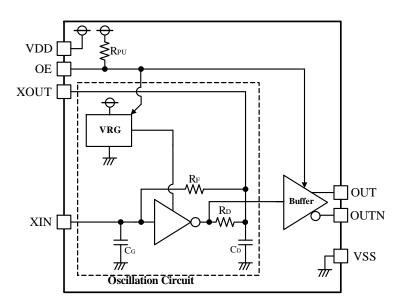
Output level:

■ Standby function:

■ Oscillation detection circuit built-in

1.71V to 1.89V3rd overtone frequency100MHz to 175MHzFundamental frequency100MHz to 175MHzf00CG, CD built-inLVDSOscillator stops, Hi-Z outputs,Power saving pull-up resistor built-in (OE output)

3. BLOCK DIAGRAM

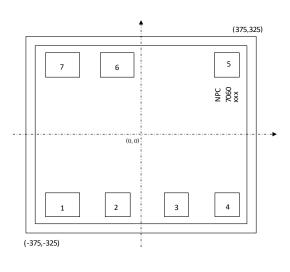


NPC

4. PAD LAYOUT

- (1) Chip size^{*1}:
- (2) Rear surface potential:
- (3) Pad size:
- (4) Chip dimensions

 $\ast 1.$ Chip size is measured between scribe line centers.



No.	X	Y	Name
1	-271	-231	VDD
2	-77	-231	XIN
3	115	-231	XOUT
4	281	-231	OE
5	281	231	VSS
6	-93	231	OUTN
7	-271	231	OUT

Pad Coordinates (Origin in chip center), Unit: [µm]

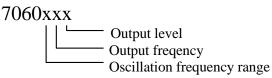
5. PAD DESCRIPTION

Number	Name	I/O ^{*1}	Function
1	VDD	-	(+) Supply voltage
2	XIN	Ι	O
3	XOUT	0	Oscillator connections
4	OE	Ι	Output enable. Outputs are disabled when OE is V _{SS} level. Disabled state: Oscillator stopped, Hi-Z outputs
5	VSS	-	(-) Supply voltage
6	OUTN	0	output (inverting output) Disabled state: Hi-Z
7	OUT	0	output Disabled state: Hi-Z

*1. I : Input, O : Output

CF7060xAV/WF7060xAV

6. VERSION LINEUP



(1) Version name 1st character (oscillation frequency range)

Version	Oscillation mode	ed C'O value		lator itance T)* ²	Oscillation frequency (reference values) f ₀ (MHz)
D	3rd overtone Fundamental	1.0~ 2.0*3	<u>С</u> _G 4	С _р 11	100~135
Е	3rd overtone Fundamental	1.0~ 2.0 ^{*3}	4	9	135~175

*1. This is the recommended range based on the circuit design.

*2. Values do not include parasitic capacitance.

*3. This version has a C0 cancel circuit to ensure negative resistance at high frequency. A self-oscillation becomes easy to happen coldly, so please be careful and do initial evaluation.

(2) Version name 2nd character (output frequency)

Version	Output frequency (f _{OUT})
А	f_0

(3) Version name 3rd character (Output level)

Version	Output level
V	LVDS

7. ABSOLUTE MAXIMUM RATINGS

					V _{SS} =0V
Parameter	Symbol	Conditions	Rating	Unit	Notes
Supply voltage range	V_{DD}	Between VDD and VSS	-0.3 ~ +4.5	V	*1
Input voltage range1	V _{IN1}	OE	-0.3 ~ V _{DD} +0.3	V	*1、*2
Input voltage range2	V _{IN2}	XIN	-0.3 ~ +2.5	V	*1、*2
Output voltage range1	V _{OUT1}	OUT,OUTN	$-0.3 \sim V_{DD} + 0.3$	V	*1、*2
Output voltage range2	V _{OUT2}	XOUT	-0.3 ~ +2.5	V	*1、*2
Junction temperature	Tj		+150	°C	*3
Storage temperature	T _{STG}	Chip, wafer form	-55 ~ +150	°C	*4

*1. Absolute maximum ratings are the values that must never exceed even for a moment. This product may suffer breakdown if any one of these parameter ratings is exceeded. Operation and characteristics are guaranteed only when the product is operated at recommended supply voltage range.

*2. V_{DD} is a V_{DD} value of recommended operating conditions.

- *3. Do not exceed the absolute maximum ratings. If they are exceeded, a characteristic and reliability will be degraded.
- *4. When stored alone in nitrogen or vacuum atmosphere.

8. RECOMMENDED OPERATING CONDITIONS

					v	SS=0V
Parameter	Symbol	Conditions	MIN	ТҮР	MAX	Unit
Oscillation frequency ^{*1}	f_0	-	100	-	175	MHz
Output frequency	f _{OUT}	-	100	-	175	MHz
Operating supply voltage	V_{DD}	VDD and VSS ^{*2}	1.71	-	1.89	v
Input voltago	V _{IN1}	OE	0	-	V _{DD}	V
Input voltage	V _{IN2}	XIN	0	-	1.89	V
Operating temperature	Ta	-	-40	-	+125	°C
Output load resistance	R _L	Between OUT and OUTN	99	100	101	Ω

*1. The oscillation frequency range is a target based on evaluation results for the crystal element used for NPC characteristics verification, and does not represent a guarantee of the oscillation frequency band. The oscillation characteristics can vary significantly depending on the characteristics and mounting conditions of the crystal. Accordingly, oscillation characteristics should be thoroughly evaluated for each crystal.

*2. For stable operation of this product, please mount ceramic chip capacitor that is more than 0.01uF between VDD and VSS in close proximity to IC (within 3mm). Wiring pattern between IC and capacitor should be as thick as possible.

* Since it may influence the reliability if it is used out of the recommended operating conditions range, this product should be used within this range.

V = 0V

9. ELECTRICAL CHARACTERISTICS

9.1. DC Characteristics

Measurement circuits 1 and 2 in "Conditions" are shown in "12. MEASUREMENT CIRCUITS."

Parameter	Symbol	Conditions	, <u>u</u>	MIN	ТҮР	MAX	Unit
Gunnal and the	I _{DDD}	Measurement circuit 1, OE=Open f ₀ =125MHz, DAVver	V _{DD} =1.8V	-	16.0	22.0	mA
Current consumption	I _{DDE}	Measurement circuit 1, OE=Open f ₀ =156MHz, EAVver	V _{DD} =1.8V	-	17.0	23.0	mA
Standby current	I _{STB}	Measurement circuit 1, $OE=V_{SS}$		-	-	30	μΑ
High-level output voltage	$V_{\rm OH}$	Measurement circuit 2,OUT/OUTN		-	1.43	1.60	V
Low-level output voltage	V _{OL}	Measurement circuit 2, OUT/OUTN		0.90	1.10	-	V
Differential output voltage	V _{OD}	Measurement circuit 2, OU	Measurement circuit 2, OUT/OUTN		330	454	mV
Differential output voltage error	ΔV_{OD}	Measurement circuit 2		-	-	50	mV
Offset voltage	V _{OS}	Measurement circuit 2, OUT-OUTN		1.125	1.250	1.375	v
Offset voltage error	ΔV_{OS}	Measurement circuit 2		-	-	50	mV

V_{DD} =1.71 to 1.89V, V_{SS} =0V, T_a =-40 to +125°C unless otherwise note	V_{DD} =1.71 to 1.89V, V_{SS} =0V, T_a =-40	to +125°C unle	ss otherwise noted
---	---	----------------	--------------------

Parameter	Symbol	Conditions	MIN	ТҮР	MAX	Unit
High-level input	V _{IH}	Measurement circuit 1, OE	$0.7V_{DD}$	-	-	V
Low-level input voltage	V _{IL}	Measurement circuit 1, OE	-	-	$0.3V_{DD}$	V
OE pull-up	R _{PU1}	Measurement circuit 1	0.5	1	2	MΩ
resistance	R _{PU2}	Measurement circuit 1	30	70	150	kΩ
Oscillator feedback resistance (Dxx ver.)	R _{FD}	Design value	1.8	2.3	2.9	kΩ
Oscillator feedback resistance (Exx ver.)	R _{FE}	Design value	1.8	2.3	2.9	kΩ
Oscillator capacitance	C _{GD}	Design value,	3.2	4.0	4.8	ъĘ
(Dxx ver.)	C _{DD}	Excludes parasitic capacitance	8.8	11.0	13.2	pF
Oscillator capacitance	C _{GE}	Design value,	3.2	4.0	4.8	лE
(Exx ver.)	C _{DE}	Excludes parasitic capacitance	7.2	9.0	10.8	pF

 V_{DD} =1.71 to 1.89V, V_{SS} =0V, T_a =-40 to +125°C unless otherwise noted

9.2. AC Characteristics

Measurement circuits 3 and 4 in "Conditions" are shown in "12. MEASUREMENT CIRCUITS."

Parameter	Symb ol	Conditions	MIN	ТҮР	MAX	Unit
Output duty cycle	Duty	Measurement circuit 3 Measured at 0V crossover point of differential output signal	45	-	55	%
Output amplitude	V _{OPP}	Measurement circuit 3 Differential output signal	0.494	-	-	v
Output rise time ^{*1}	t _r	Measurement circuit 3 Measured between 20% and 80% amplitude of differential output signal	-	200	400	ps
Output fall time ^{*1}	t _f	Measurement circuit 3 Measured between 80% and 20% amplitude of differential output signal	-	200	400	ps
Output disable time ^{*1}	t _{OD}	Measurement circuit 4 Time measured OE=V _{IL} (falling edge) and outputs going Hi-Z (see timing diagram for details)	-	-	200	ns

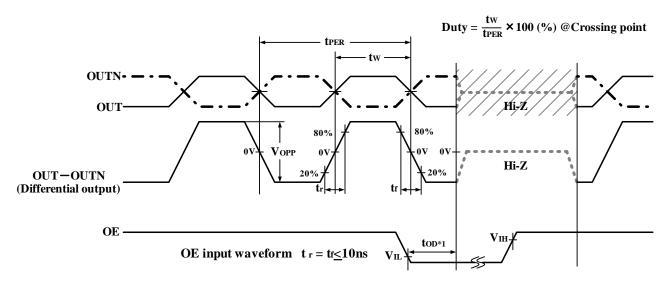
*1. Since shipping inspection is not possible, it is guaranteed by characterization.

* The ratings above are values obtained by measurements using an NPC evaluation standard crystal element, standard testing jig, and evaluation package.

Ratings may have wide tolerances due to crystal element characteristics, evaluation jig, and package parasitic capacitance, so thorough evaluation is recommended.

9.3. Timing Diagram

The timing diagram applies to the "Conditions" in the table in "9.2. AC Characteristics."

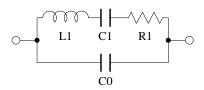


*1. When OE turns into LOW from HIGH, the output becomes Hi-Z.

図 9. LVDS Timing diagram

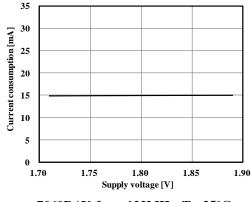
10. REFERENCE CHARACTERISTICS (Typical 7060 Characteristics)

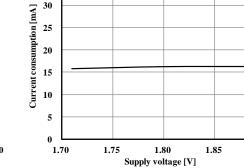
The following characteristics assume the use of the following crystal element. The characteristics will vary depending on the crystal used and the measurement conditions.



Parameter	f ₀ =122MHz	f ₀ =155.52MHz
C0(pF)	1.7	1.5
$R1(\Omega)$	9	11
Oscillation mode	Fundamental	Fundamental



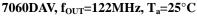




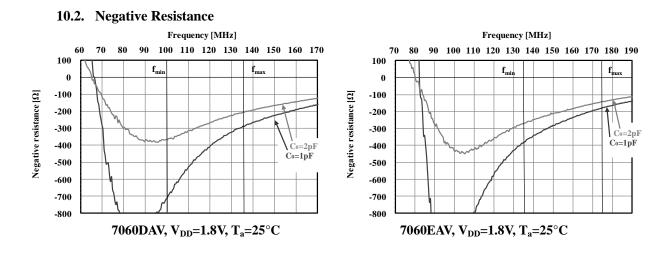
35

30

25



7060EAV, f_{OUT} =155.52MHz, T_a =25°C



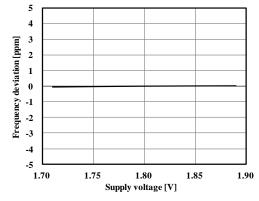
NPC

Document No.DE200421.doc **CONFIDENTIAL**

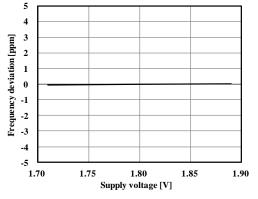
1.90

CF7060xAV/WF7060xAV

10.3. Frequency Deviation vs. Voltage



7060DAV, f_{OUT}=122MHz, T_a=25°C, 1.8V std.



7060EAV, f_{OUT}=155.52MHz, T_a=25°C, 1.8V std.

7060EAV, f_{OUT}=155.52MHz, T_a=25°C

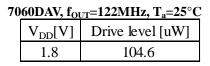
Drive level [uW]

131.3

 $V_{DD}[V]$

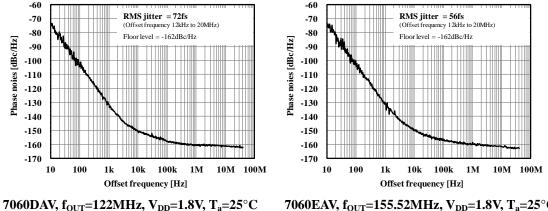
1.8

10.4. Drive Level



10.5. Phase Noise

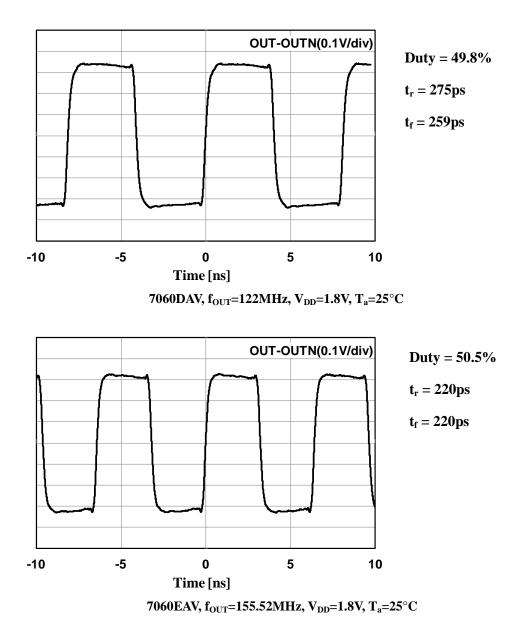
Measurement instrument: Agilent E5052B Signal Source Analyzer





10.6. Output Waveforms

Measuring instrument: Agilent 80604B Oscilloscope



11. FUNCTIONAL DESCRIPTION

11.1. OE Function

When OE turns into V_{SS} , the OUT/OUTN outputs stop and become high impedance. This function is used to disable the operation of the device.

OE input	OUT/OUTN outputs	Oscillator circuit
V _{DD} or Open	f ₀ output	Operating
V _{SS}	Hi-Z	Stopped

11.2. Power Saving Pull-up Resistor

The pull-up resistor built in the OE pin switches to RPU1 or RPU2 depending on the input level ("VDD" or "VSS").

Fixing the OE pin to the VSS level increases the pull-up resistance value (RPU1) and reduces current consumption.

When the OE pin is used with VDD or open, the pull-up resistance value becomes small (RPU2) and it is less susceptible to external noise.

This fixes the inside of the OE pin to the VDD level and avoids the problem of output stopping suddenly.

11.3. Oscillation Detection Function

The IC has a built-in oscillation detection circuit.

The oscillation detection circuit disables the output circuit when the oscillator starts until the oscillation becomes stable. This function avoids the danger of unstable oscillation when the oscillator starts after power is first applied or the output is enabled.

11.4. C0 cancellation circuit

Oscillation circuit with a built-in C0 cancellation circuit provides a fixed compensation amount to cancel the effect of the crystal C0. It reduces the C0 parameter in the equivalent circuit, reducing the shallow negative resistance for increasing values of C0.

This cancellation circuit makes it easier to maintain the oscillation margin.

12. MEASUREMENT CIRCUITS

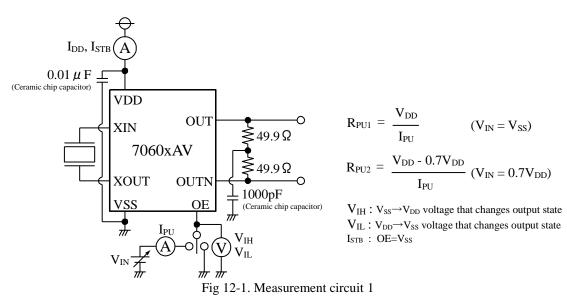
These measurement circuits are used for DC and AC characteristics evaluation.

***** Cautions for output waveform *****

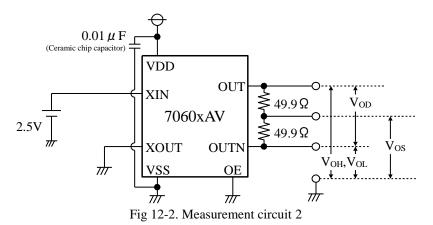
To obtain good waveform characteristics, place a ceramic chip capacitor of 0.01 μ F (or more) between the VDD and VSS pins of the IC (within about 3 mm).

12.1. LVDS

• Measurement circuit 1 Measurement parameters: I_{DD}, I_{STB}, V_{II}, V_{IL}, R_{PU1}, R_{PU2}

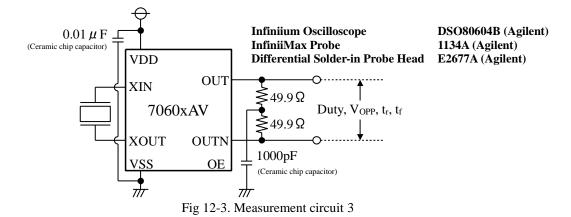


• Measurement circuit 2 Measurement parameters: V_{OH}, V_{OL}, V_{OD}, V_{OS}

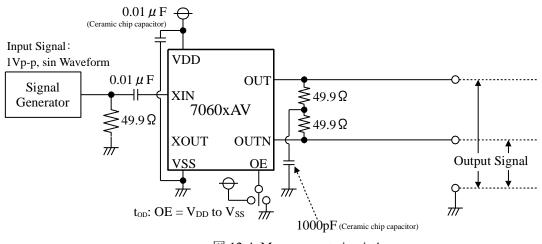


CF7060xAV/WF7060xAV

• Measurement circuit 3 Measurement parameters: Duty, V_{OPP}, t_r, t_f



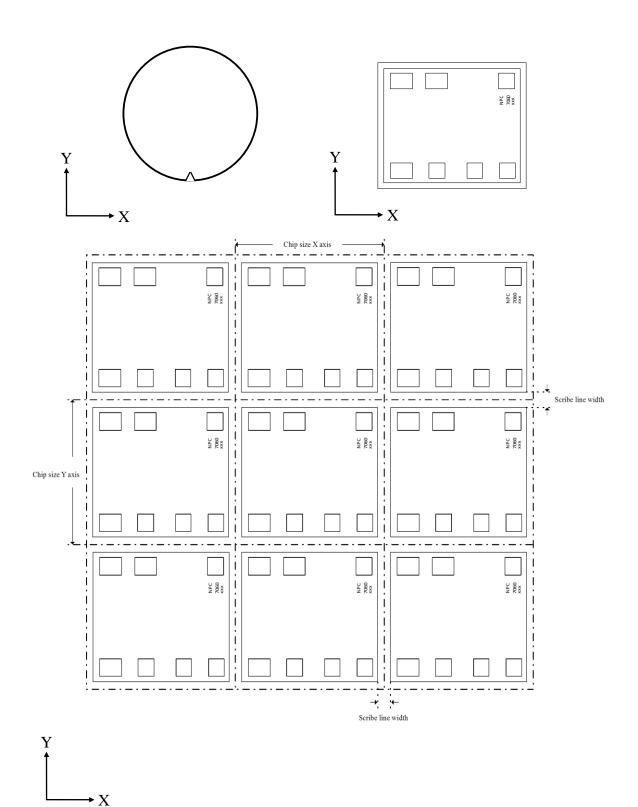






13. WAFER SURFACE DIAGRAM

Wafer size:200mm±0.5mmScribe line width:60μm

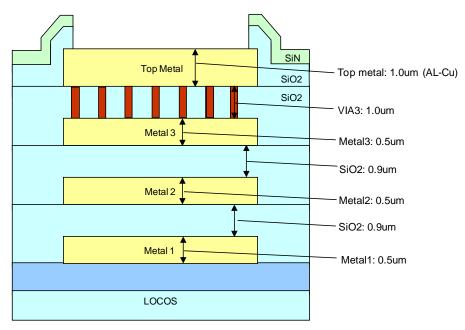


NPC

Document No.DE200421.doc CONFIDENTIAL

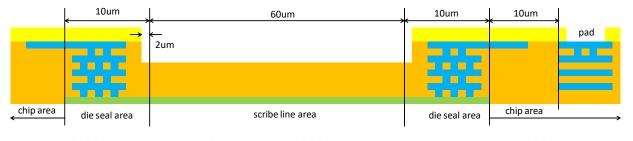
14. CROSS SECTION STRUCTURE

14.1. PAD Cross Section Structure



*Film thickness of mention is a value in the designs as above and is not the actual value in the chip.

14.2. Seal Ring and Scribe Line Cross Section Structure



*Width of mention is a value in the designs as above and is not the actual value in the chip.

<Notes on UBM formation>

In UBM (Under Bump Metal) formation to the mounting pad electrode by electroless plating, UBM is similarly formed on the scribe line TEG and the metal exposed part of the accessory. So mask process covering the scribe line is required to prevent these effects.

15. USAGE AND PRECAUTIONS

This product is designed and manufactured to the generally accepted standards of reliability as expected for use in general electronic and electrical equipment, such as personal equipment, machine tools, and measurement equipment. This product is not designed and manufactured to be used in any other special equipment requiring extremely high level of reliability and safety, such as aerospace equipment, nuclear power control equipment, medical equipment, transportation equipment, disaster prevention equipment, security equipment.

If you wish to use this product in equipment requiring extremely high level of reliability, please contact our sales department or representative in advance.

In the event that this product is used in such equipment, please take scrupulous care and apply fail-safe techniques including redundancy and malfunction prevention in order to prevent damage to life, health, property, or infrastructure etc. in case there is some malfunction in the product.

Please pay your attention to the following points at time of using the products shown in this document.

1. The products shown in this document (hereinafter "Products") are designed and manufactured to the generally accepted standards of reliability as expected for use in general electronic and electrical equipment, such as personal equipment, machine tools and measurement equipment. The Products are not designed and manufactured to be used in any other special equipment requiring extremely high level of reliability and safety, such as aerospace equipment, nuclear power control equipment, medical equipment, transportation equipment, disaster prevention equipment, security equipment. The Products are not designed and manufactured to be used for the apparatus that exerts harmful influence on the human lives due to the defects, failure or malfunction of the Products.

If you wish to use the Products in that apparatus, please contact our sales section in advance.

In the event that the Products are used in such apparatus without our prior approval, we assume no responsibility whatsoever for any damages resulting from the use of that apparatus.

- 2. NPC reserves the right to change the specifications of the Products in order to improve the characteristics or reliability thereof.
- 3. The information described in this document is presented only as a guide for using the Products. No responsibility is assumed by us for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of the third parties. Then, we assume no responsibility whatsoever for any damages resulting from that infringements.
- 4. The constant of each circuit shown in this document is described as an example, and it is not guaranteed about its value of the mass production products.
- 5. In the case of that the Products in this document falls under the foreign exchange and foreign trade control law or other applicable laws and regulations, approval of the export to be based on those laws and regulations are necessary. Customers are requested appropriately take steps to obtain required permissions or approvals from appropriate government agencies.

SEIKO NPC CORPORATION

2-9-4, Taito, Taito-ku, Tokyo 110-0016, Japan Telephone: +81-3-6747-5300 Facsimile: +81-3-6747-5303 http://www.npc.co.jp/ Email:sales@npc.co.jp

DE200421E 2021.1

NPC